

Dual P-Channel Enhancement Mode Power MOSFET

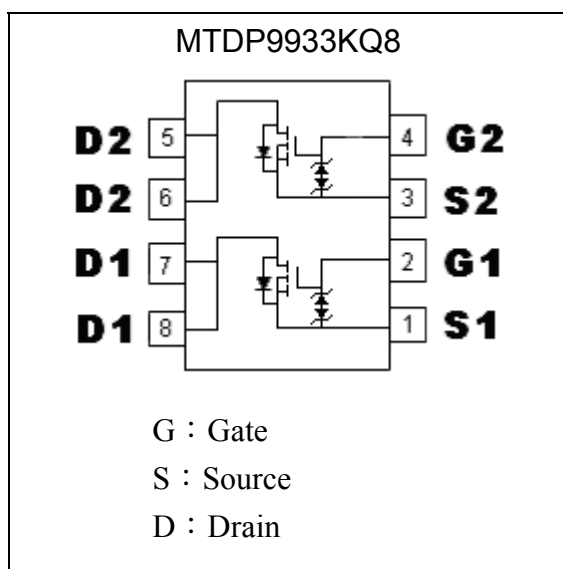
MTDP9933KQ8

Features

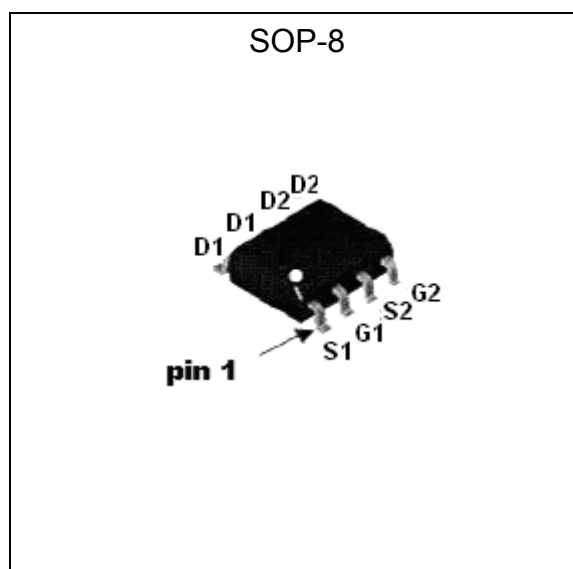
- Simple drive requirement
- Low on-resistance
- Fast switching speed
- Pb-free lead plating and halogen-free package
- ESD protected device

BVDSS	-20V
ID@VGS=-4.5V, TA=25°C	-4.5A
ID@VGS=-4.5V, TC=25°C	-7.5A
RDSON@VGS=-4.5V, ID=-4A	28 mΩ (typ)
RDSON@VGS=-2.5V, ID=-4A	36 mΩ (typ)
RDSON@VGS=-1.8V, ID=-2A	44 mΩ (typ)

Equivalent Circuit

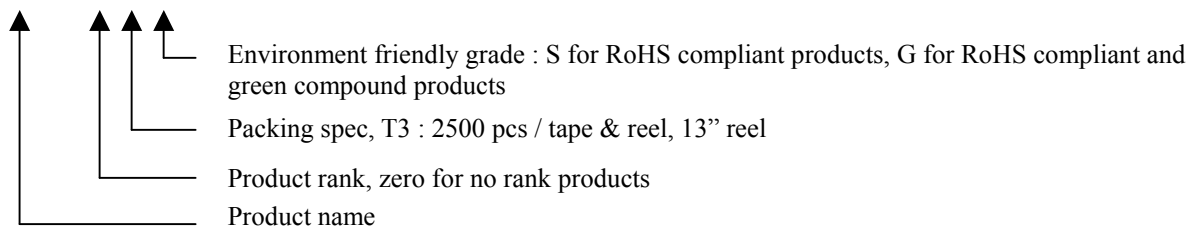


Outline



Ordering Information

Device	Package	Shipping
MTDP9933KQ8-0-T3-G	SOP-8 (Pb-free lead plating and halogen-free package)	2500 pcs / tape & reel



**Absolute Maximum Ratings** ($T_a=25^{\circ}\text{C}$)

Parameter		Symbol	10s	Steady State	Unit
Drain-Source Voltage		V _{DS}	-20		V
Gate-Source Voltage		V _{GS}	±8		
Continuous Drain Current @ T _C =25°C, V _{GS} =-4.5V (Note1)		I _D	-7.5		A
Continuous Drain Current @ T _C =100°C, V _{GS} =-4.5V (Note1)			-4.7		
Continuous Drain Current @ T _A =25°C, V _{GS} =-4.5V (Note2)		I _{DSM}	-6.0	-4.5	
Continuous Drain Current @ T _A =70°C, V _{GS} =-4.5V (Note2)			-4.8	-3.6	
Pulsed Drain Current (Note3)		I _{DM}	-40 *1,2		
Total Power Dissipation	T _C =25°C (Note1)	P _D	3.1		W
	T _C =100°C (Note1)		1.2		
	T _A =25°C (Note2)	P _{DSM}	2.0	1.1	
	T _A =70°C (Note2)		1.3	0.7	
Operating Junction and Storage Temperature Range		T _j , T _{stg}	-55~+150		°C

Thermal Data

Parameter		Symbol	Typical	Maximum	Unit
Thermal Resistance, Junction-to-case		$R_{th,j-c}$	34	40	$^{\circ}\text{C/W}$
Thermal Resistance, Junction-to-ambient (Note2)	$t \leq 10\text{s}$	$R_{th,j-a}$	58	62.5	
	Steady State		91	110	

Note : 1. The power dissipation P_D is based on $T_{J(MAX)}=150^{\circ}\text{C}$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

2. The value of $R_{\theta JA}$ is measured with the device mounted on 1 in² FR-4 board with 2 oz. copper, in a still air environment with $T_A=25^{\circ}\text{C}$. The power dissipation P_{DSM} is based on $R_{\theta JA}$ and the maximum allowed junction temperature of 150°C . The value in any given application depends on the user's specific board design.

3. Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}=150^{\circ}\text{C}$. Ratings are based on low frequency and low duty cycles to keep initial $T_J=25^{\circ}\text{C}$.

Electrical Characteristics ($T_c=25^{\circ}\text{C}$, unless otherwise noted)

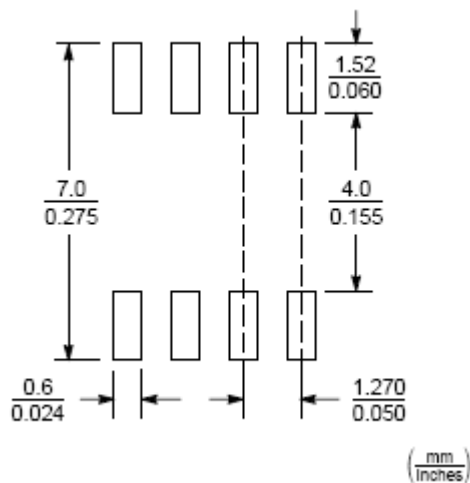
Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV_{DSS}	-20	-	-	V	$V_{GS}=0\text{V}$, $I_D=-250\mu\text{A}$
$V_{GS(th)}$	-0.3	-	-0.9		$V_{DS}=V_{GS}$, $I_D=-250\mu\text{A}$
I_{GSS}	-	-	± 10	μA	$V_{GS}=\pm 8\text{V}$, $V_{DS}=0\text{V}$
I_{DSS}	-	-	-1		$V_{DS}=-20\text{V}$, $V_{GS}=0\text{V}$
I_{DSS}	-	-	-5		$V_{DS}=-20\text{V}$, $V_{GS}=0$, $T_j=55^{\circ}\text{C}$
$R_{DS(ON)}$ (Note 1)	-	28	38	$\text{m}\Omega$	$I_D=-4\text{A}$, $V_{GS}=-4.5\text{V}$
	-	36	48		$I_D=-4\text{A}$, $V_{GS}=-2.5\text{V}$
	-	44	62		$I_D=-2\text{A}$, $V_{GS}=-1.8\text{V}$
G_{FS} (Note 1)	-	30	-	S	$V_{DS}=-5\text{V}$, $I_D=-3\text{A}$



Dynamic					
Ciss	-	828	1242	pF	V _{DS} =-10V, V _{GS} =0, f=1MHz
Coss	-	134	201		
Crss	-	127	191		
t _d (ON) (Note 1&2)	-	4.2	6.3	ns	V _{DS} =-5V, I _D =-0.5A, V _{GS} =-4.5V, R _G =6Ω
t _r (Note 1&2)	-	23.6	35.4		
t _d (OFF) (Note 1&2)	-	54.6	81.9		
t _f (Note 1&2)	-	28.8	43.2		
Q _g (Note 1&2)	-	10.6	15.9	nC	V _{DS} =-10V, I _D =-3.8A, V _{GS} =-4.5V
Q _{gs} (Note 1&2)	-	1.2	-		
Q _{gd} (Note 1&2)	-	3.9	-		
R _g	-	5.8	-	Ω	f=1MHz
Source-Drain Diode					
I _S	-	-	-1.7	A	
I _{SM} (Note 3)	-	-	-10		
V _{SD} (Note 1)	-	-0.76	-1	V	I _S =-1A, V _{GS} =0V
t _{rr}	-	22.3	-	ns	I _F =-1.3A, dI _F /dt=100A/μs
Q _{rr}	-	4.4	-	nC	

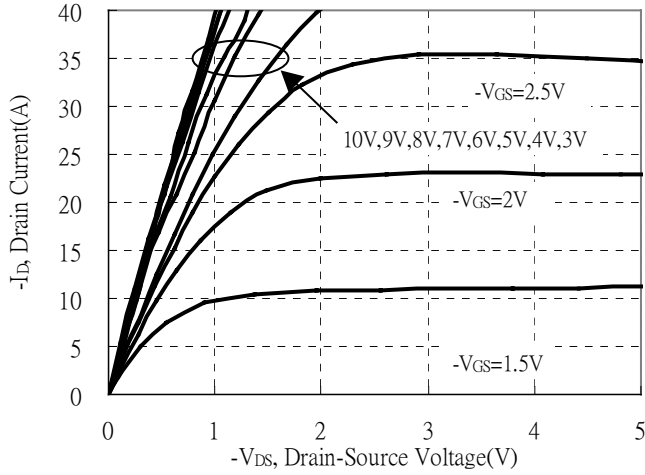
Note : 1.Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%
2.Independent of operating temperature
3.Pulse width limited by maximum junction temperature

Recommended Soldering Footprint

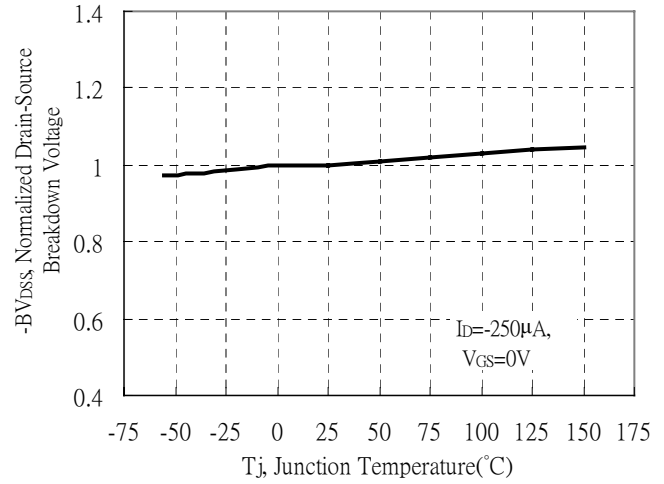


Typical Characteristics

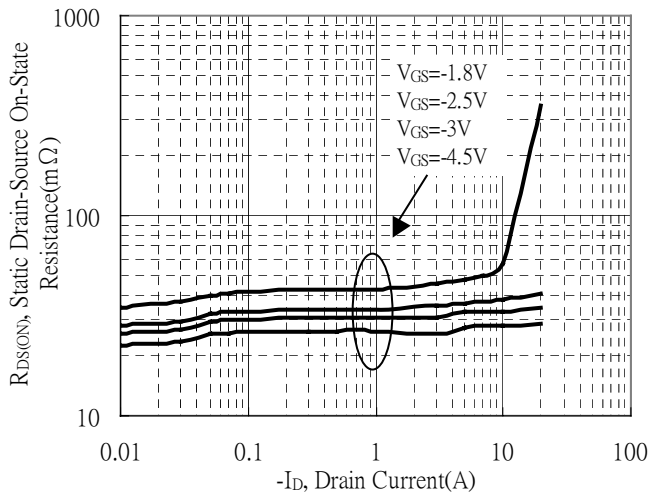
Typical Output Characteristics



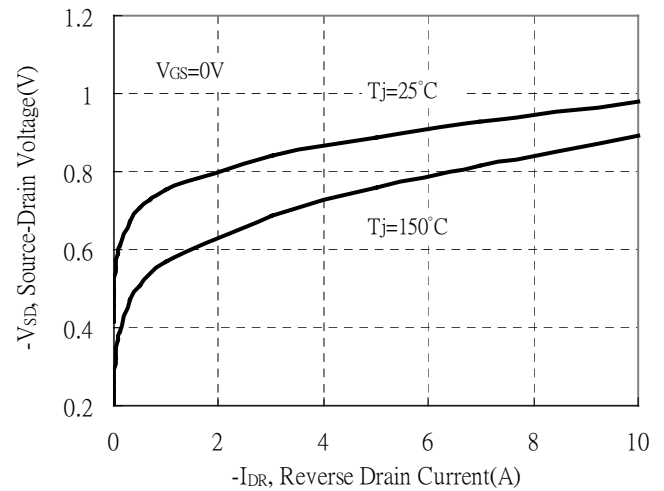
Breakdown Voltage vs Ambient Temperature



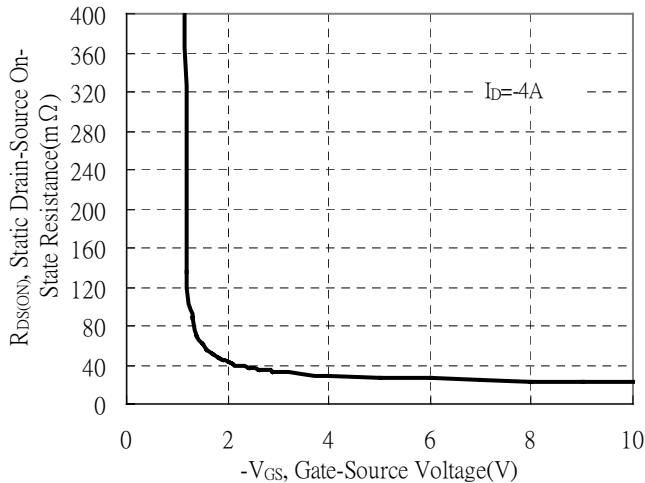
Static Drain-Source On-State resistance vs Drain Current



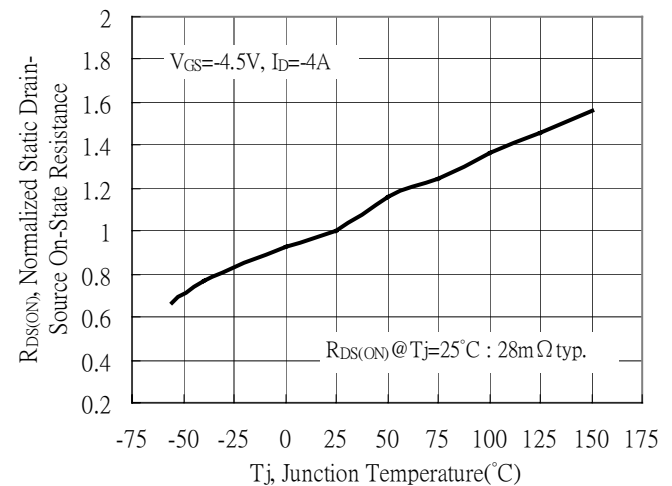
Reverse Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

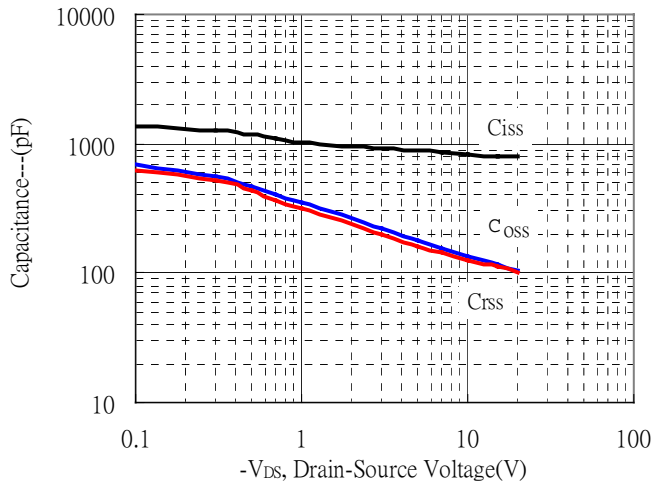


Drain-Source On-State Resistance vs Junction Temperature

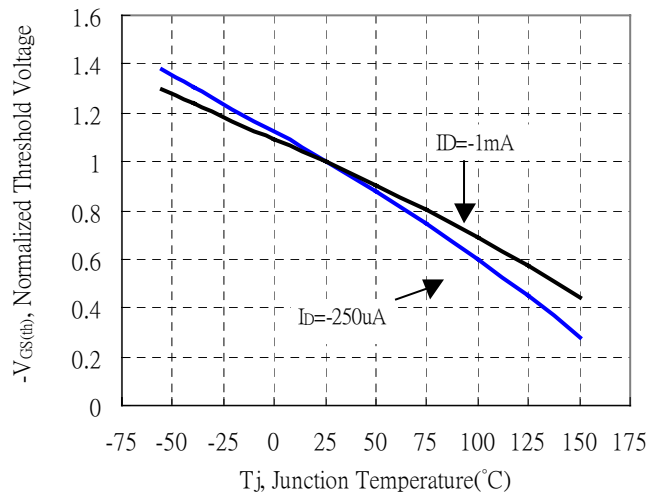


Typical Characteristics(Cont.)

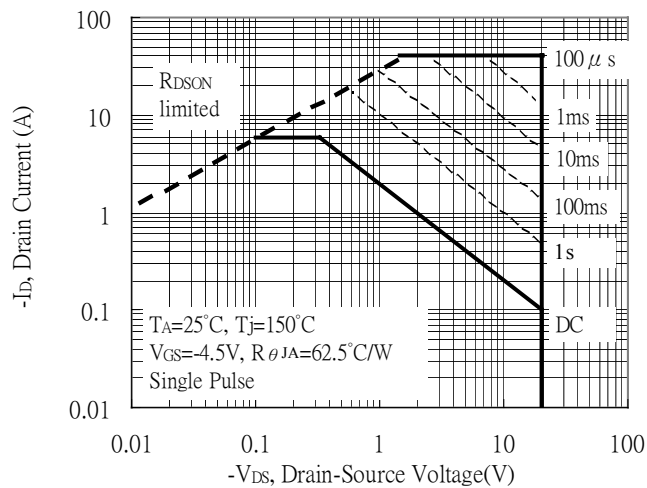
Capacitance vs Drain-to-Source Voltage



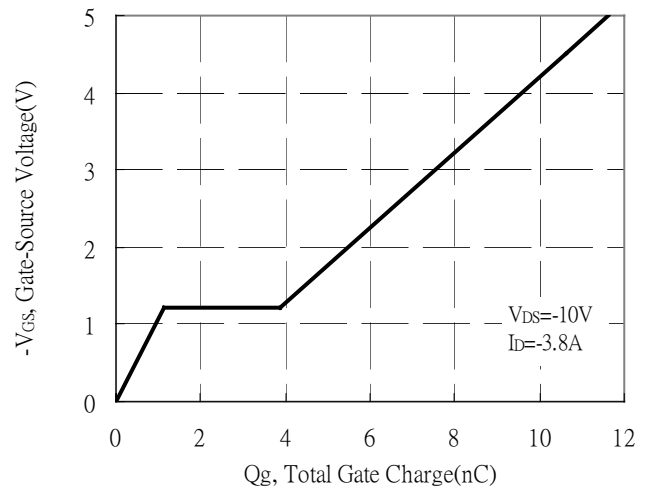
Threshold Voltage vs Junction Temperature



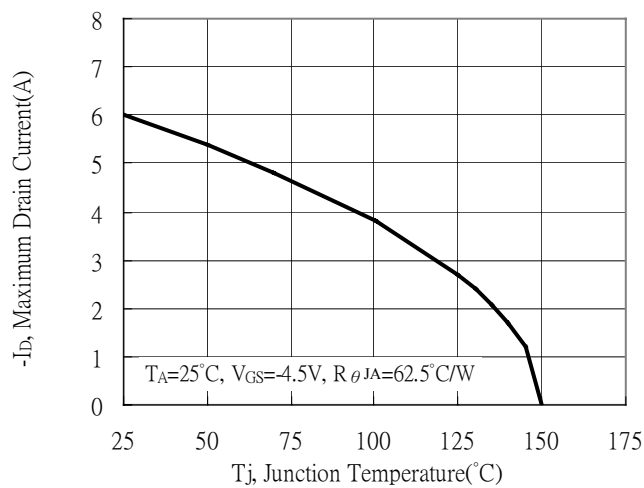
Maximum Safe Operating Area



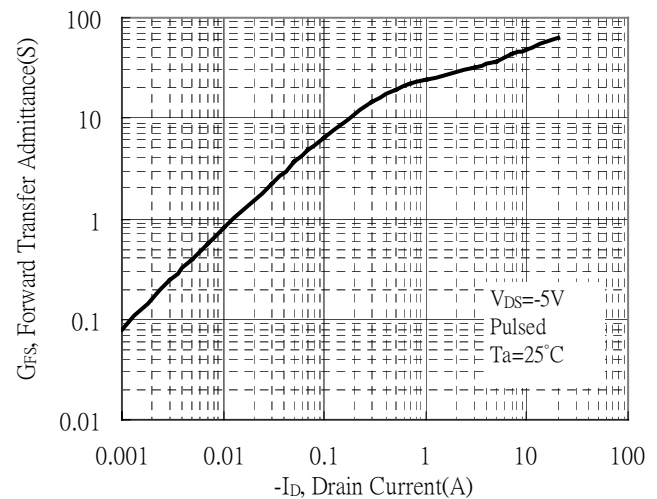
Gate Charge Characteristics



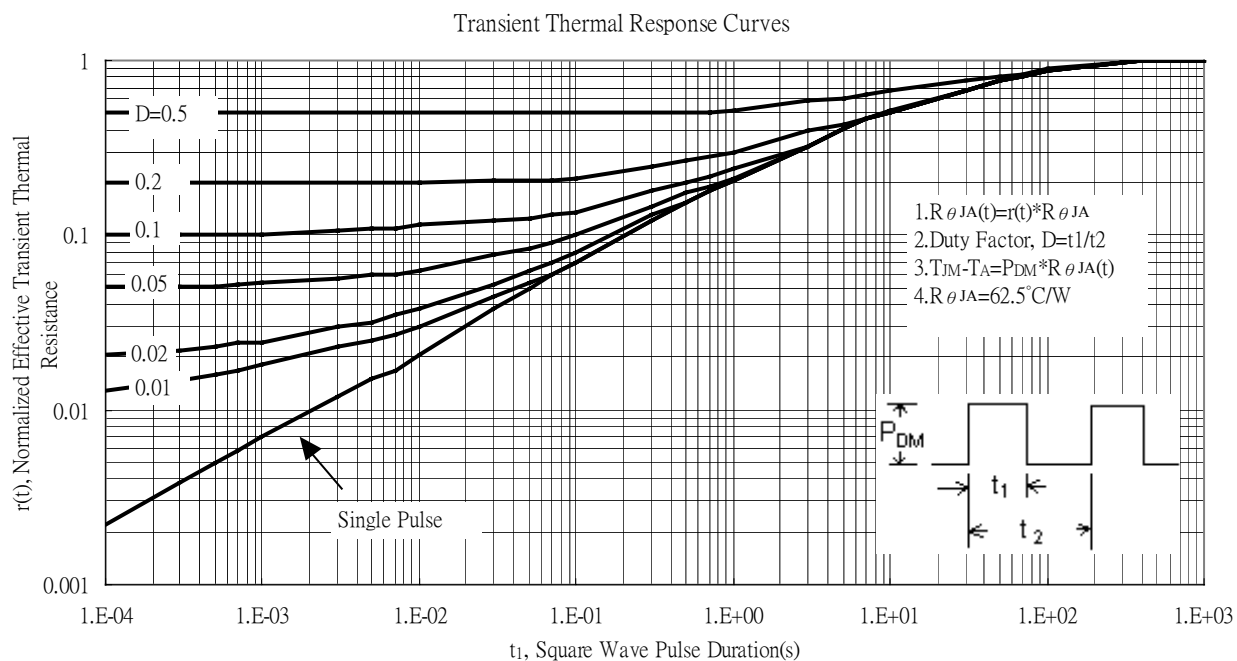
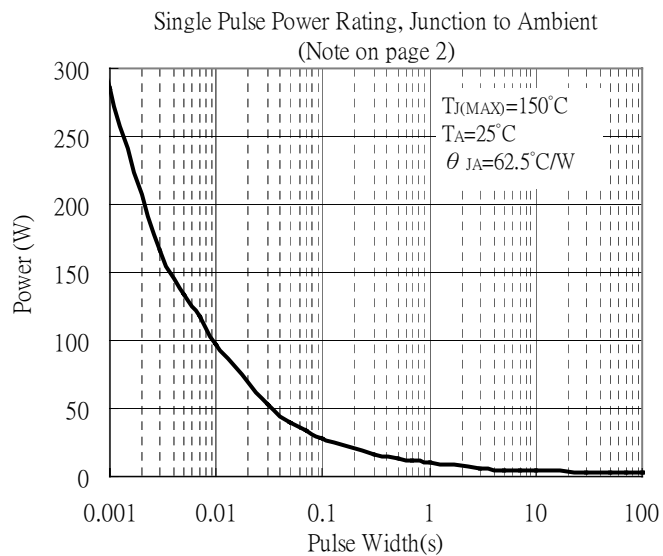
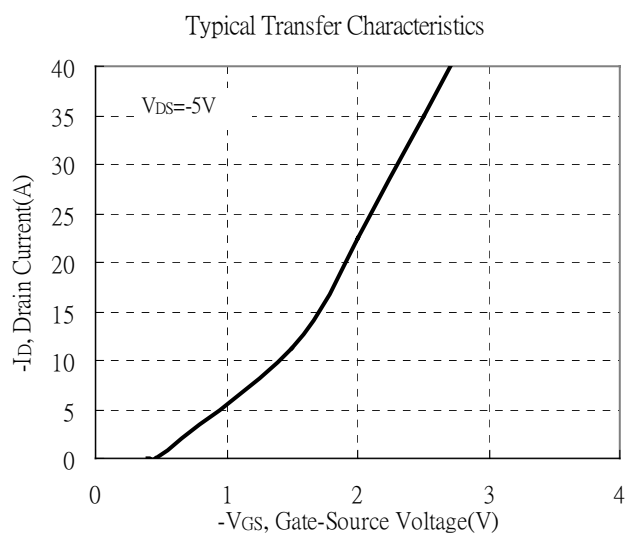
Maximum Drain Current vs Junction Temperature



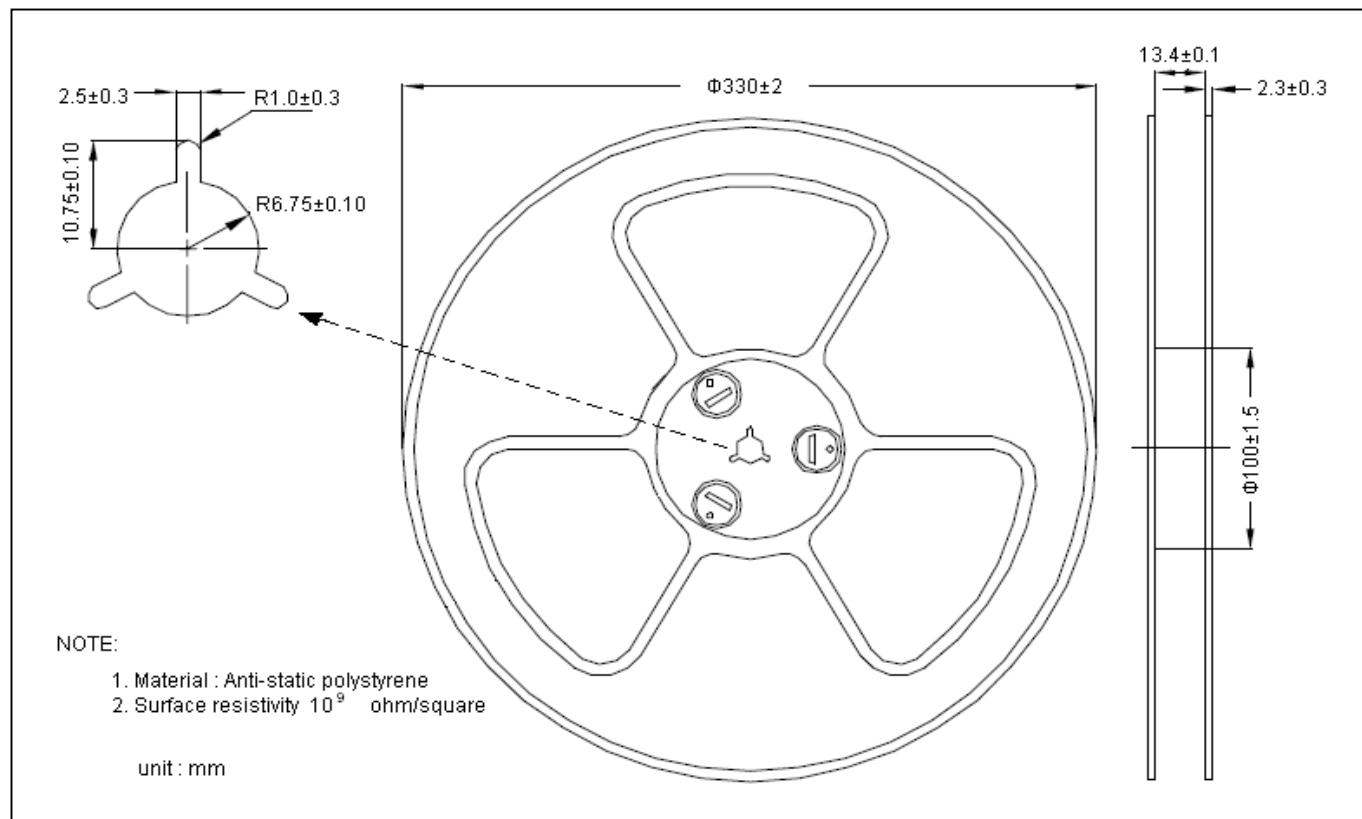
Forward Transfer Admittance vs Drain Current



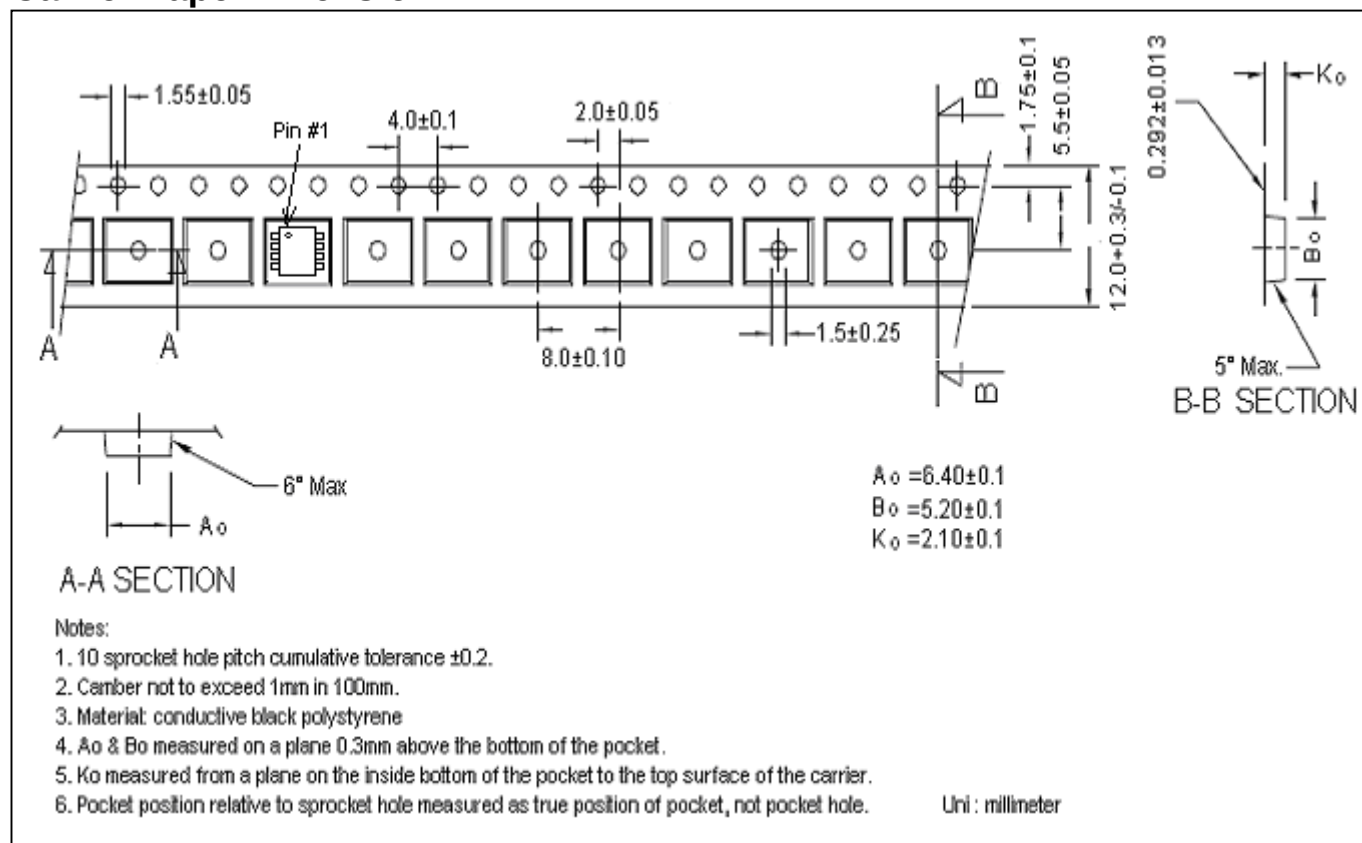
Typical Characteristics(Cont.)



Reel Dimension



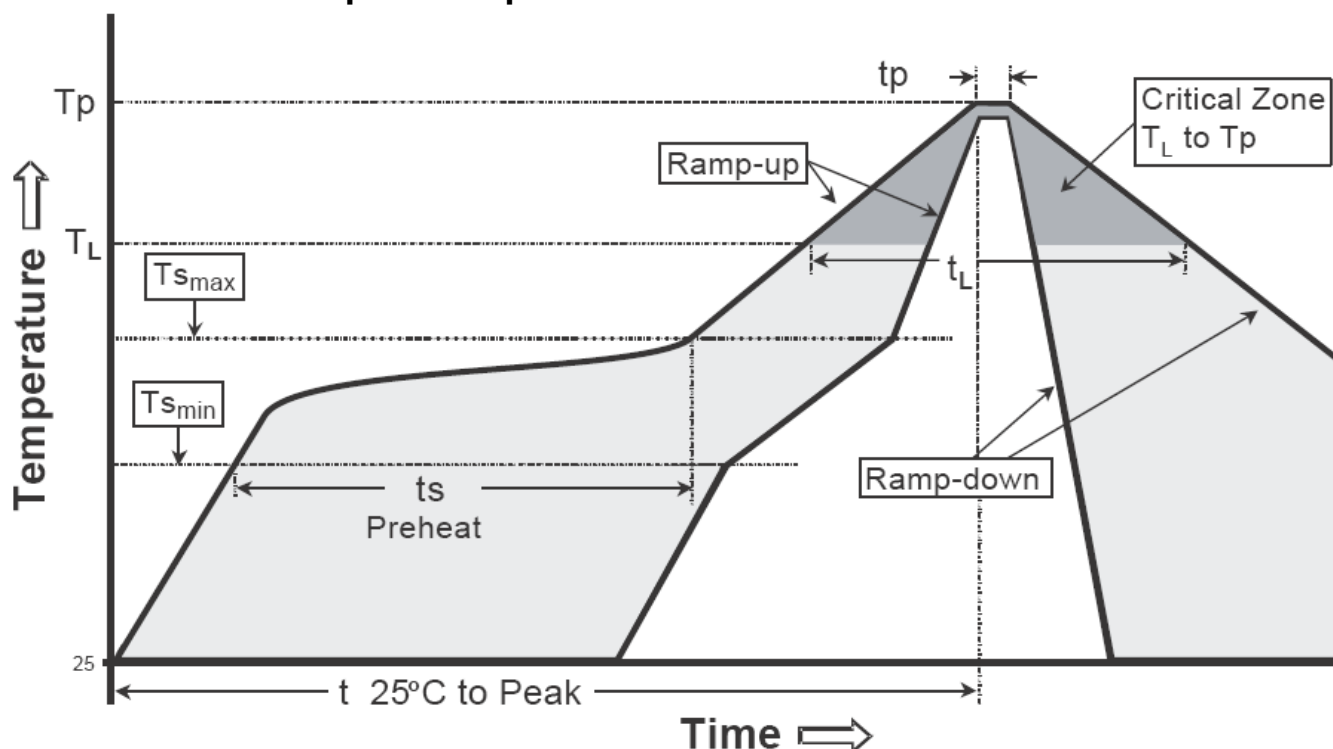
Carrier Tape Dimension



Recommended wave soldering condition

Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

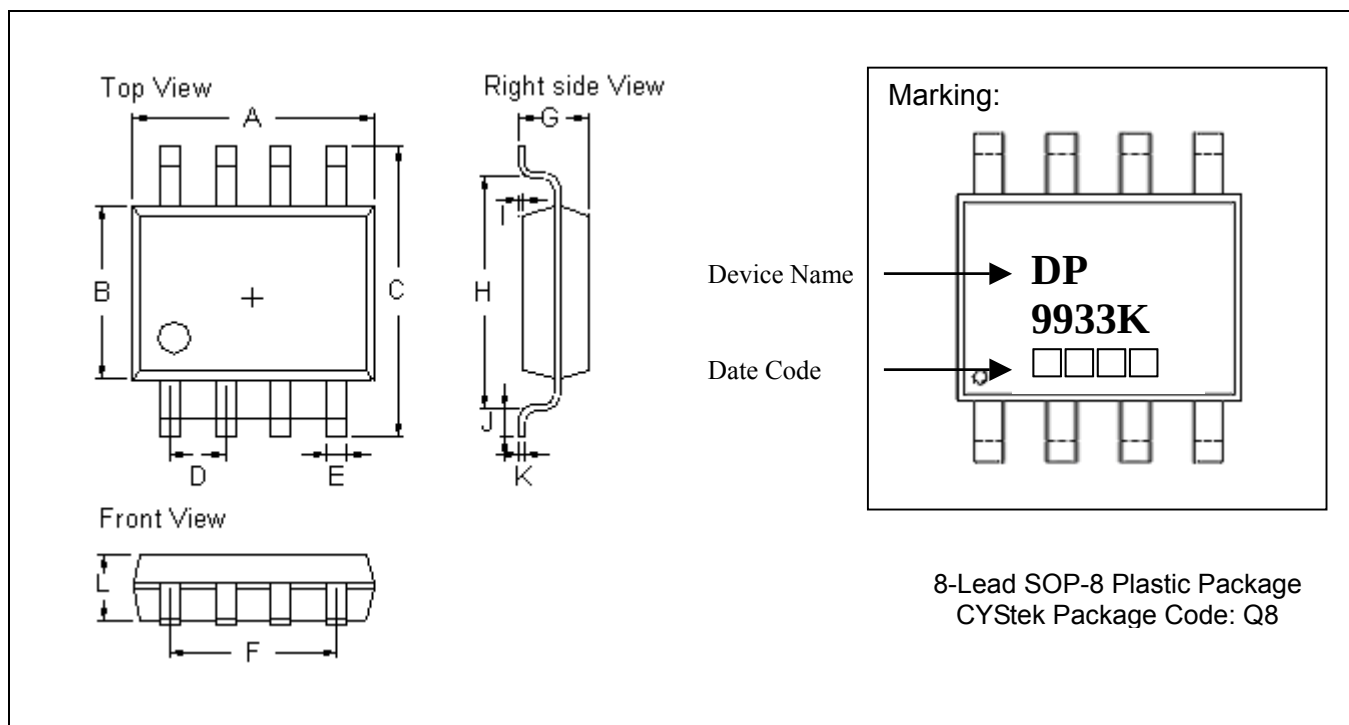
Recommended temperature profile for IR reflow



Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (Tsmax to Tp)	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(Ts min)	100°C	150°C
-Temperature Max(Ts max)	150°C	200°C
-Time(ts min to ts max)	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (Tl)	183°C	217°C
- Time (tL)	60-150 seconds	60-150 seconds
Peak Temperature(Tp)	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(tp)	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

Note : All temperatures refer to topside of the package, measured on the package body surface.

SOP-8 Dimension



*: Typical

DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.1850	0.2007	4.70	5.10	G	0.0531	0.0689	1.35	1.75
B	0.1496	0.1575	3.80	4.00	H	0.1889	0.2007	4.80	5.10
C	0.2283	0.2441	5.80	6.20	I	0.0019	0.0098	0.05	0.25
D	0.0500*		1.27 *		J	0.0157	0.0500	0.40	1.27
E	0.0130	0.0201	0.33	0.51	K	0.0067	0.0098	0.17	0.25
F	0.1472	0.1527	3.74	3.88	L	0.0531	0.0610	1.35	1.55

Notes: 1.Controlling dimension: millimeters.

2.Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.

3.If there is any question with packing specification or packing method, please contact your local CYStek sales office.

Material:

- Lead: Pure tin plated.
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0.

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